## **VT 1000 DL**



## VERTICAL DOWNWARD LOOKING INTERFROMETER SYSTEM

- precision vertical downward looking interferometer system for full aperture testing of optics in production-, quality inspection- and metrology lab environments
- optimized for the use in combination with sub-aperture polishing- and correction processes on flat optics, spheres and aspheres
- integrated features and technologies for perfect alignment of measuring data with the coordinate system/axis of sub aperture correction machines for achievement of highest correction quality and efficiency
- natural granite column with extremely flat and precise guiding surfaces provide for ease of use and very accurate measurement of radius of curvature on optical components
- highly precise and accurate linear scale with exceptional resolution, directly interfaced to fringe analysis software
- \_ measurement table(s) is balanced and guided on air bearing slide for quick, easy and accurate setup and movement
- \_ fully closed measuring area with innovative door system for precise and reliable, undisturbed measurements
- robust vibration damping system, prefect for use in industrial production environments
- XONOX X-fiz 100 (4") or X-fiz 130 (5.2") high performance Fizeau interferometer with electronic control of optical zoom (1x to 10x), focus and contrast
- <u>\_</u> innovative, powerful and user friendly fringe analysis sys-tem **X-fringe2** with different smart and intelligent modes to suit various applications
- \_ choose from low cost "ST" version with static fringe analysis up to high performance "PS2" phase shifting version
- \_ additionally available in a "tower only" version "B" for integrating existing or 3rd party interferometer units or version "Z" equipped with ZYGO Verifire and ZYGO MX fringe analysis software

WORKING RANGE	min. 1000mm travel, up to 250mm test diameter (depending on used TS and part holder) + micrometer fine adjustment for easy and precise adjustment of cats eye and confocal position
VERSIONS	_ VT1000 DL ST with XONOX X-fiz 100 (4") / X-fiz 130 (5.2") with 10x optical zoom and static fringe analysis system XONOX "X-fringe ST"
	_ VT1000 DL PS2 with XONOX X-fiz 100 (4") / X-fiz 130 (5.2") with 10x optical zoom, phase shifting fringe analysis system XONOX "X-fringe2" and piezo phase shifter XONOX "X-phase PMR"
	_ VT1000 DL Z with ZYGO Verifire 4" or 6" interferometer unit and Mx / MetroPro phase shifting fringe analysis
	<b>_ VT1000 DL B</b> "tower only" version for integrating existing interferometer units. Optionally with XONOX fringe analysis system X-fringe ST or X-fringe PS with X-phase PMR phase shifter.
	_ All versions can be equipped with 1 or 2 meausring slides and CGH multi axis holder on request
MEASURING SYSTEM	incremental high precision linear measuring system with PC interface + attachment SRM-plus for short radius measurement (option) or laser distance measuring system (option)
MEASURING ACCURACY	up to +/- 0.7 $\mu$ per 500mm , up to 1 nanometer resolution
DIMENSIONS (WxDxH) / WEIGHT	$1200 \times 900 \times 2800 \text{ mm}$ (additional space required if PC is used for fringe analysis, XONOX PC-table optionally available) / approx. $950 \text{kg}$
CONNECTIONS	110-240 V / 50-60 Hz, compressed air: 6 bar
COLOR	Light grey RAL 7035

